

Notice of References Cited	Application/Control No. 10/085,298	Applicant(s)/Patent Under Reexamination LAMOTHE ET AL.	
	Examiner Minh Dieu Nguyen	Art Unit 2137	Page 1 of 1

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	U	Microchip 25AA040/25LC040/25C040, pp 1-20
	V	Freescale Semiconductor, Inc. MPC862SR, pp1-6
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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